



Power MOSFET

Features

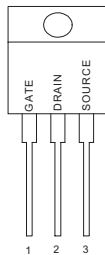
- Dynamic dv/dt Rating
- Repetitive Avalanche Rated
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements

General Description

This Power MOSFET is designed for low voltage, high speed power switching applications such as switching regulators, converters, solenoid and relay drivers.

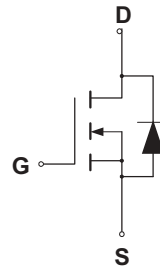
Pin Configuration

TO-220
Top View



Symbol

N-Channel MOSFET



Ordering Information

Part Number	Package
CTM09N20N220	TO-220

Absolute Maximum Ratings

Rating	Symbol	Value	Unit
Drain Current – Continuous	I_D	9.0	A
	I_{DM}	36	
Gate-to-Source Voltage – Continuous	V_{GS}	± 20	V
Total Power Dissipation Derate above 25°C	P_D	74	W
		0.59	W/°C
Single Pulse Avalanche Energy(Note 2)	E_{AS}	250	mJ
Avalanche Current(Note 1)	I_{AR}	9.0	A
Repetitive Avalanche Energy(Note 1)	E_{AR}	7.4	mJ
Peak Diode Recovery dv/dt (Note 3)	dv/dt	5.0	V/ns
Operating and Storage Temperature Range	T_J, T_{STG}	-55 to 150	°C
Thermal Resistance – Junction to Case – Junction to Ambient	θ_{JC}	1.70	°C/W
	θ_{JA}	62	
Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	T_L	300	°C



Electrical Characteristics

Unless otherwise specified, $T_J = 25^\circ\text{C}$.

Characteristic	Symbol	CTM09N20			Units	
		Min	Typ	Max		
Drain-Source Breakdown Voltage ($V_{GS} = 0\text{ V}$, $I_D = 250\ \mu\text{A}$)	$V_{(BR)DSS}$	200			V	
Drain-Source Leakage Current ($V_{DS} = 200\text{V}$, $V_{GS} = 0\text{ V}$) ($V_{DS} = 160\text{V}$, $V_{GS} = 0\text{ V}$, $T_J = 125^\circ\text{C}$)	I_{DSS}			25 250	μA	
Gate-Source Leakage Current-Forward ($V_{GS} = 20\text{ V}$, $V_{DS} = 0\text{ V}$)	I_{GSSF}			100	nA	
Gate-Source Leakage Current-Reverse ($V_{GS} = -20\text{ V}$, $V_{DS} = 0\text{ V}$)	I_{GSSR}			-100	nA	
Gate Threshold Voltage ($V_{DS} = V_{GS}$, $I_D = 250\ \mu\text{A}$)	$V_{GS(th)}$	2.0		4.0	V	
Static Drain-Source On-Resistance ($V_{GS} = 10\text{ V}$, $I_D = 5.4\text{A}$) (Note 4)	$R_{DS(on)}$			0.40	Ω	
Forward Transconductance ($V_{DS} = 50\text{V}$, $I_D = 5.4\text{ A}$) (Note 4)	g_{FS}	3.8			S	
Input Capacitance	$(V_{DS} = 25\text{ V}$, $V_{GS} = 0\text{ V}$, $f = 1.0\text{ MHz}$)	C_{iss}		800	pF	
Output Capacitance		C_{oss}		240	pF	
Reverse Transfer Capacitance		C_{riss}		76	pF	
Turn-On Delay Time	$(V_{DD} = 100\text{ V}$, $I_D = 5.9\text{ A}$, $R_G = 12\ \Omega$, $R_D = 16\ \Omega$) (Note 4)	$t_{d(on)}$		9.4	ns	
Rise Time		t_r		28	ns	
Turn-Off Delay Time		$t_{d(off)}$		39	ns	
Fall Time		t_f		20	ns	
Total Gate Charge		$(V_{DS} = 160\text{V}$, $I_D = 5.9\text{A}$, $V_{GS} = 10\text{ V}$) (Note 4)	Q_g		43	nC
Gate-Source Charge	Q_{gs}			7.0	nC	
Gate-Drain Charge	Q_{gd}			23	nC	
Internal Drain Inductance (Measured from the drain lead 0.25" from package to center of die)	L_D		4.5		nH	
Internal Drain Inductance (Measured from the source lead 0.25" from package to source bond pad)	L_S		7.5		nH	
SOURCE-DRAIN DIODE CHARACTERISTICS						
Reverse Recovery Charge	$I_F = 5.9\text{A}$, $di/dt = 100\text{A}/\mu\text{s}$ (Note 4)	Q_{rr}		1.1	2.2	μC
Forward Turn-On Time		t_{on}		**		
Reverse Recovery Time		t_{rr}		170	340	ns
Diode Forward Voltage	$I_S = 9.0\text{A}$, $V_{GS} = 0\text{ V}$, $T_J = 25^\circ\text{C}$ (Note 4)	V_{SD}		2.0		V

Note

- (1) Repetitive rating; pulse width limited by max. junction temperature
- (2) $V_{DD} = 50\text{V}$, starting $T_J = 25^\circ\text{C}$, $V_{GS} = 10\text{V}$, $L = 4.6\text{mH}$, $R_G = 25\ \Omega$, $I_L = 9.0\text{A}$
- (3) $I_{SD} \leq 9.0\text{A}$, $di/dt \leq 120\text{A}/\mu\text{s}$, $V_{DD} \leq V_{(BR)DSS}$, $T_J \leq 150^\circ\text{C}$
- (4) Pulse Test: Pulse Width $\leq 300\ \mu\text{s}$, Duty Cycle $\leq 2\%$

** Negligible, Dominated by circuit inductance



Typical Electrical Characteristics

Figure 1. Typical Output Characteristics, $T_c=25^\circ\text{C}$

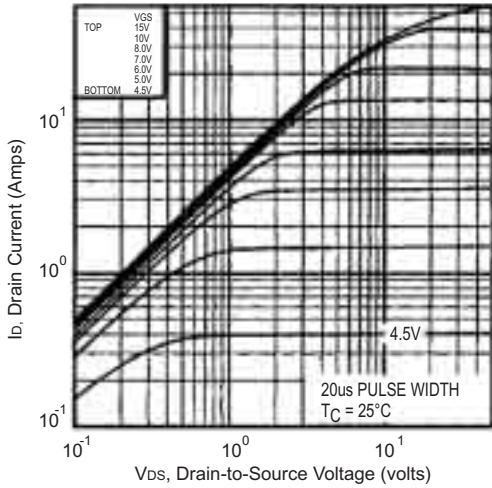


Figure 2. Typical Output Characteristics, $T_c=150^\circ\text{C}$

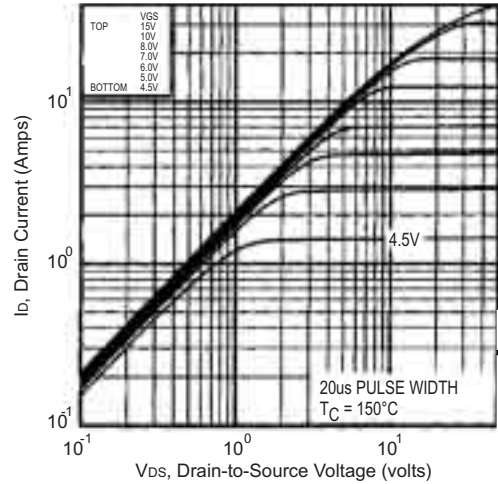


Figure 3. Typical Transfer Characteristics

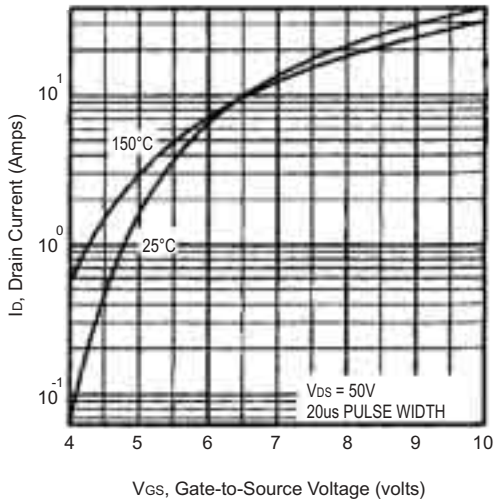


Figure 4. Normalized On-Resistance Vs. Temperature

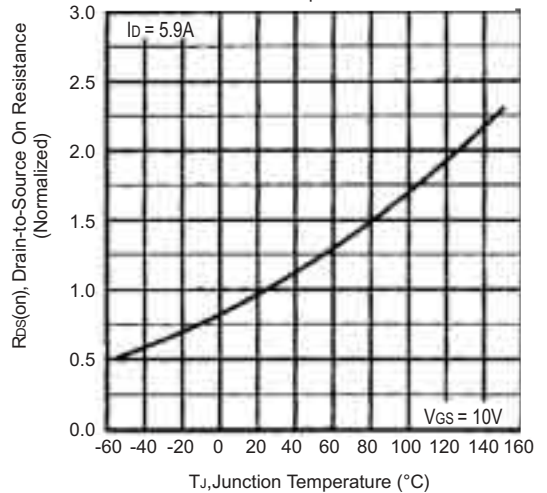




Figure 5. Typical Capacitance Vs. Drain-to-Source Voltage

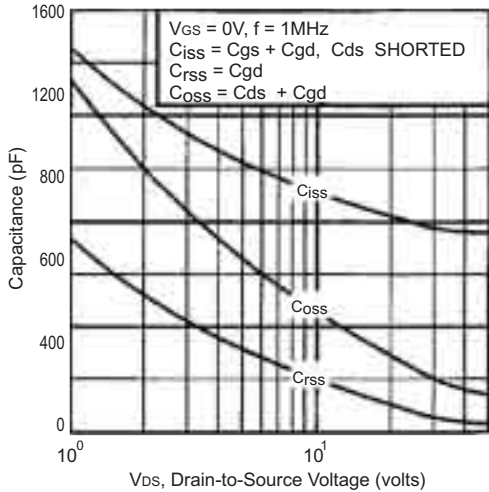


Figure 6. Typical Gate Charge Vs. Gate-to-Source Voltage

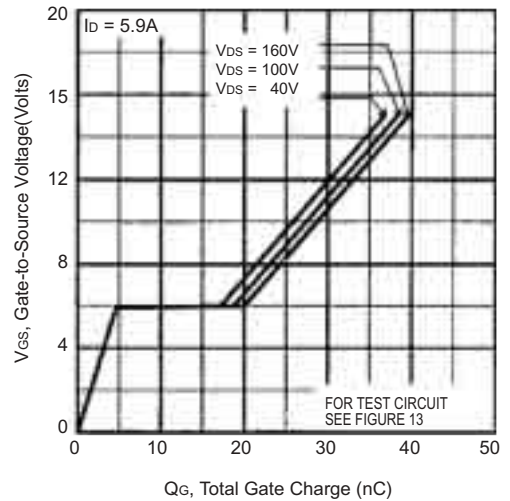


Figure 7. Typical Source-Drain Diode Forward Voltage

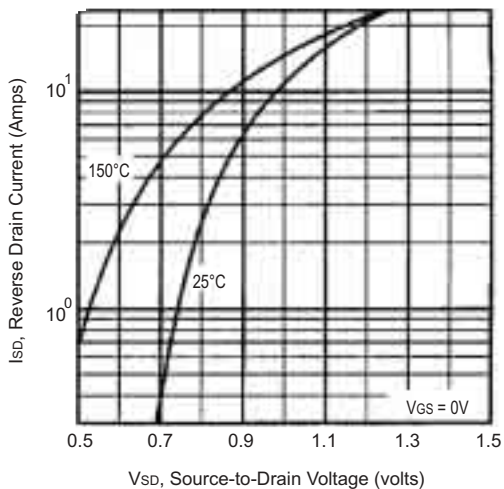


Figure 8. Maximum Safe Operating Area

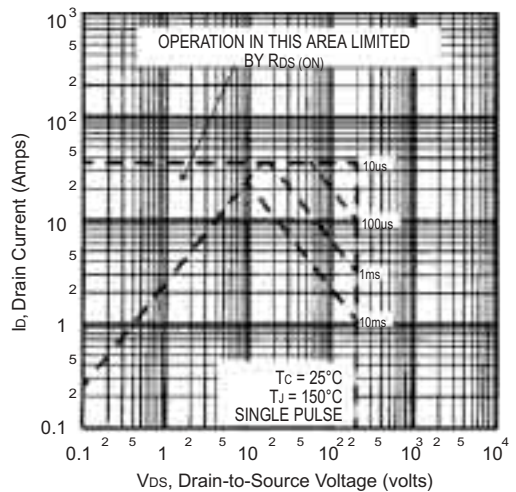




Figure 9. Maximum Drain Current Vs. Case Temperature

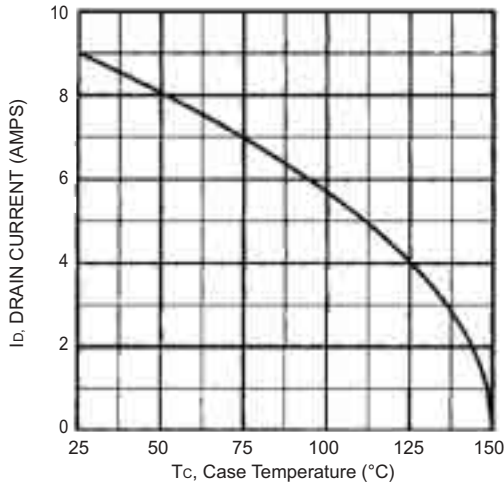


Figure 10a. Switching Time Test Circuit

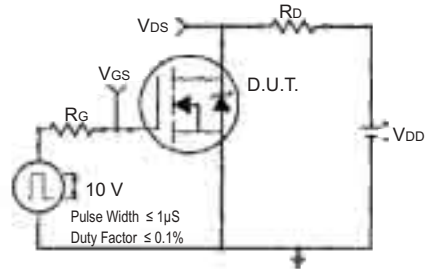


Figure 10b. Switching Time Waveforms

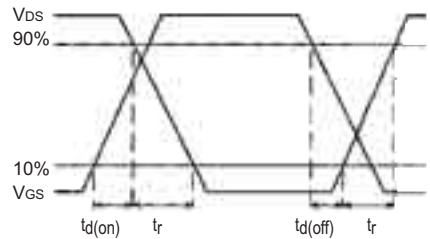


Figure 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

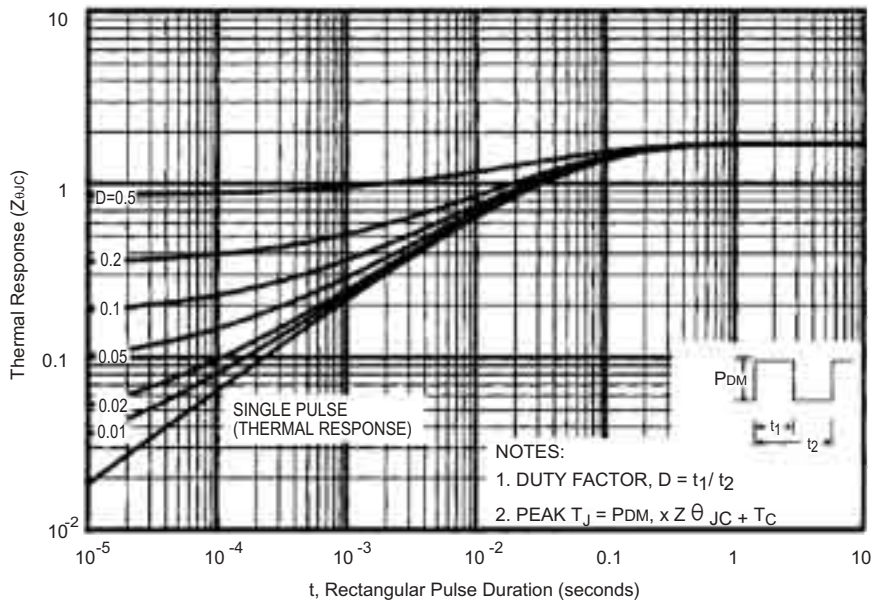




Figure 12a. Unclamped Inductive Test Circuit

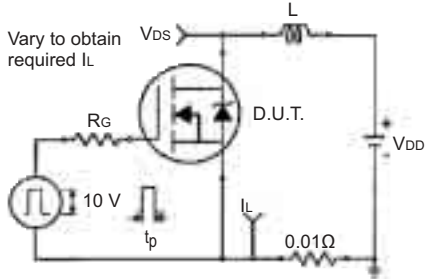


Figure 12b. Unclamped Inductive Waveforms

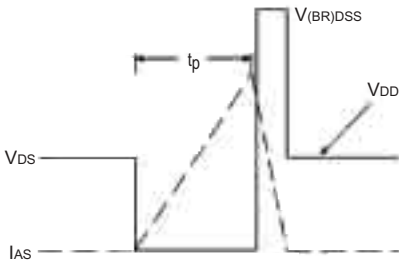


Figure 13. Basic Gate Charge Waveform

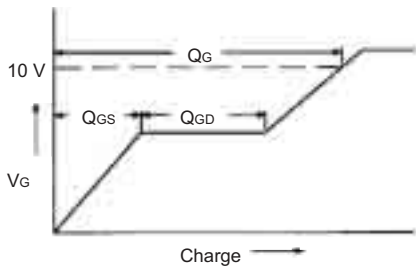


Figure 12c. Maximum Aalanche Energy Vs. Drain Current

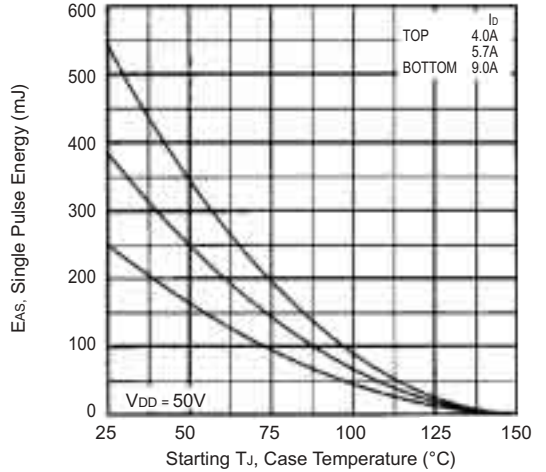
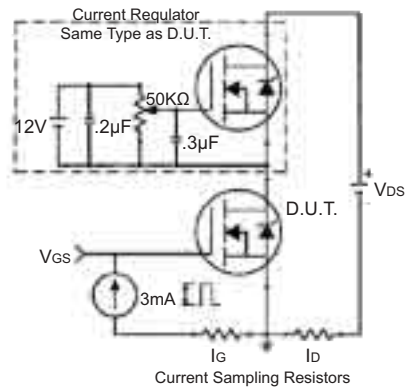


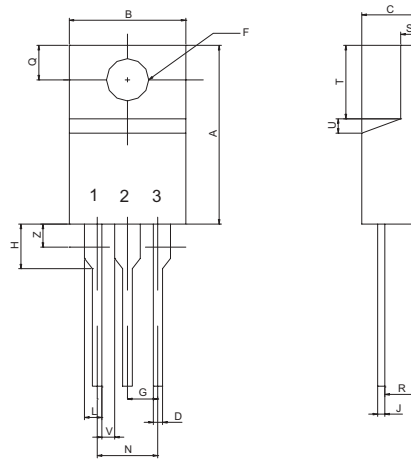
Figure 13b. Gate Charge Test Circuit





Package Dimension

TO-220



PIN 1: GATE
 PIN 2: DRAIN
 PIN 3: SOURCE

SYMBOLS	DIMENSIONS IN MILLIMETERS			DIMENSIONS IN INCHS		
	MIN	NOM	MAX	MIN	NOM	MAX
A	14.48	---	15.75	0.570	---	0.620
B	9.66	---	10.28	0.380	---	0.405
C	4.07	---	4.82	0.160	---	0.190
D	0.64	---	0.88	0.025	---	0.035
F	3.61	---	3.73	0.142	---	0.147
G	2.42	---	2.66	0.095	---	0.105
H	2.80	---	3.93	0.110	---	0.155
J	0.46	---	0.64	0.018	---	0.025
K	12.70	---	14.27	0.500	---	0.562
L	1.15	---	1.52	0.045	---	0.060
N	4.83	---	5.33	0.190	---	0.210
Q	2.54	---	3.04	0.100	---	0.120
R	2.04	---	2.79	0.080	---	0.110
S	1.15	---	1.39	0.045	---	0.055
T	5.97	---	6.47	0.235	---	0.255
U	0.00	---	1.27	0.000	---	0.050
V	1.15	---	---	0.045	---	---
Z	---	---	2.04	---	---	0.080